

WINNER-TAKE-ALL NETWORKS OF $O(N)$ COMPLEXITY

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INTRODUCTION

Two general types of inhibition mediate activity in neural systems: subtractive inhibition, which sets a zero level for the computation, and multiplicative (nonlinear) inhibition, which regulates the gain of the computation. We report a physical realization of general nonlinear inhibition in its extreme form, known as *winner-take-all*.

We have designed and fabricated a series of compact, completely functional CMOS integrated circuits that realize the winner-take-all function, using the full analog nature of the medium. This circuit has been used successfully as a component in several VLSI sensory systems, that perform auditory localization (Lazzaro and Mead, in press) and visual stereopsis (Mahowald and Delbruck, 1988). Winner-take-all circuits with over 170 inputs function correctly in these sensory systems.

We have also modified this global winner-take-all circuit, realizing a circuit that computes local nonlinear inhibition. The circuit allows multiple winners in the network, and is well suited for use in systems that represent a feature space topographically and that process several features in parallel. We have designed, fabricated, and tested a CMOS integrated circuit that computes locally the winner-take-all function of spatially ordered input.

THE WINNER-TAKE-ALL CIRCUIT

Figure 1 is a schematic diagram of the winner-take-all circuit. A single wire, associated with the potential V_c , computes the inhibition for the entire circuit; for an n neuron circuit, this wire is $O(n)$ long. To compute the global inhibition, each neuron k contributes a current onto this common wire, using transistor T_{2k} . To apply this global inhibition locally, each neuron responds to the common wire voltage V_c , using transistor T_{1k} . This computation is continuous in time; no clocks are used. The circuit exhibits no hysteresis, and operates with a time constant related to the size of the largest input. The output representation of the circuit is not binary; the winning output encodes the logarithm of its associated input.

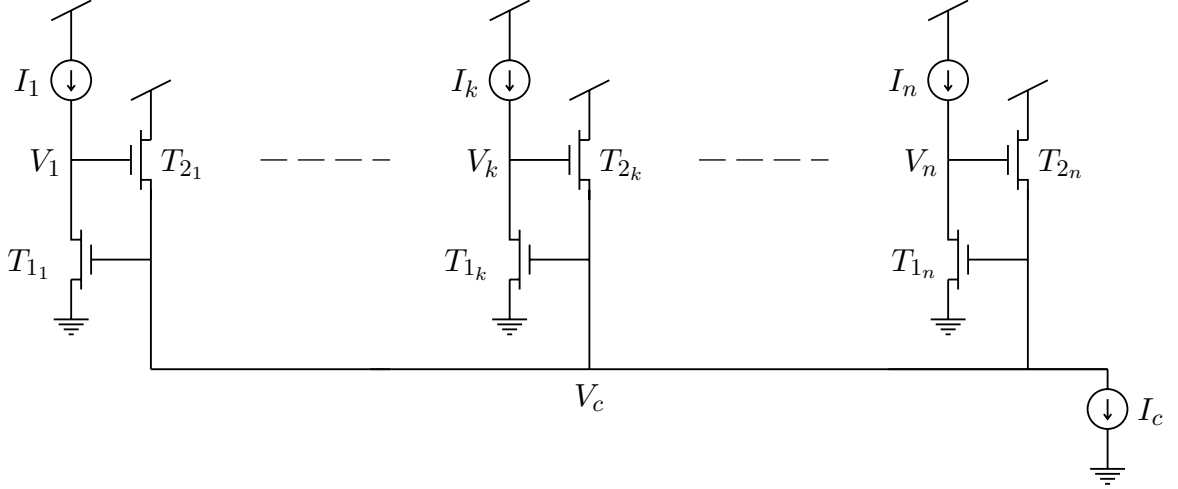


Figure 1 Schematic diagram of the winner-take-all circuit. Each neuron receives a unidirectional current input I_k ; the output voltages $V_1 \dots V_n$ represent the result of the winner-take-all computation. If $I_k = \max(I_1 \dots I_n)$, then V_k is a logarithmic function of I_k ; if $I_j \ll I_k$, then $V_j \approx 0$.

A static and dynamic analysis of the two-neuron circuit illustrates these system properties. Figure 2 shows a schematic diagram of a two-neuron winner-take-all circuit. To understand the behavior of the circuit, we first consider the input condition $I_1 = I_2 \equiv I_m$. Transistors T_{1_1} and T_{1_2} have identical potentials at gate and source, and are both sinking I_m ; thus, the drain potentials V_1 and V_2 must be equal. Transistors T_{2_1} and T_{2_2} have identical source, drain, and gate potentials, and therefore must sink the identical current $I_{c_1} = I_{c_2} = I_c/2$. In the subthreshold region of operation, the equation $I_m = I_o \exp(V_c/V_o)$ describes transistors T_{1_1} and T_{1_2} , where I_o is a fabrication parameter, and $V_o = kT/q\kappa$. Likewise, the equation $I_c/2 = I_o \exp((V_m - V_c)/V_o)$, where $V_m \equiv V_1 = V_2$, describes transistors T_{2_1} and T_{2_2} . Solving for $V_m(I_m, I_c)$ yields

$$V_m = V_o \ln\left(\frac{I_m}{I_o}\right) + V_o \ln\left(\frac{I_c}{2I_o}\right). \quad (1)$$

Thus, for equal input currents, the circuit produces equal output voltages; this behavior is desirable for a winner-take-all circuit. In addition, the output voltage V_m logarithmically encodes the magnitude of the input current I_m .

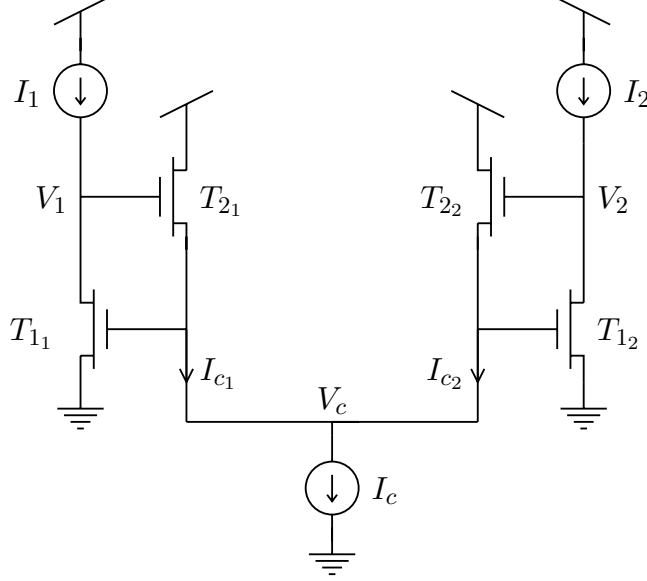


Figure 2 Schematic diagram of a two-neuron winner-take-all circuit.

The input condition $I_1 = I_m + \delta_i$, $I_2 = I_m$ illustrates the inhibitory action of the circuit. Transistor T_{11} must sink δ_i more current than in the previous example; as a result, the gate voltage of T_{11} rises. Transistors T_{11} and T_{12} share a common gate, however; thus, T_{12} must also sink $I_m + \delta_i$. But only I_m is present at the drain of T_{12} . To compensate, the drain voltage of T_{12} , V_2 , must decrease. For small δ_i s, the Early effect serves to decrease the current through T_{12} , decreasing V_2 linearly with δ_i . For large δ_i s, T_{12} must leave saturation, driving V_2 to approximately 0 volts. As desired, the output associated with the smaller input diminishes. For large δ_i s, $I_{c2} \approx 0$, and $I_{c1} \approx I_c$. The equation $I_m + \delta_i = I_o \exp(V_c/V_o)$ describes transistor T_{11} , and the equation $I_c = I_o \exp((V_1 - V_c)/V_o)$ describes transistor T_{21} . Solving for V_1 yields

$$V_1 = V_o \ln\left(\frac{I_m + \delta_i}{I_o}\right) + V_o \ln\left(\frac{I_c}{I_o}\right). \quad (2)$$

The winning output encodes the logarithm of the associated input. The symmetrical circuit topology ensures similar behavior for increases in I_2 relative to I_1 .

Equation 2 predicts the winning response of the circuit; a more complex expression, derived in Appendix A, predicts the losing and crossover response of the circuit. Figure 3 is a plot of this analysis, fit to experimental data.

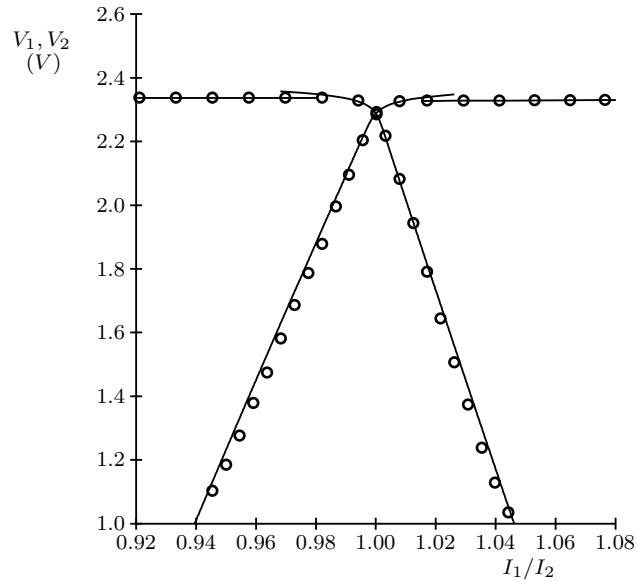


Figure 3 Experimental data (circles) and theoretical statements (solid lines) for a two-neuron winner-take-all circuit. I_1 , the input current of the first neuron, is swept about the value of I_2 , the input current of the second neuron; neuron voltage outputs V_1 and V_2 are plotted versus normalized input current.

Figure 4 shows the wide dynamic range and logarithmic properties of the circuit; the experiment in Figure 3 is repeated for several values of I_2 , ranging over four orders of magnitude.

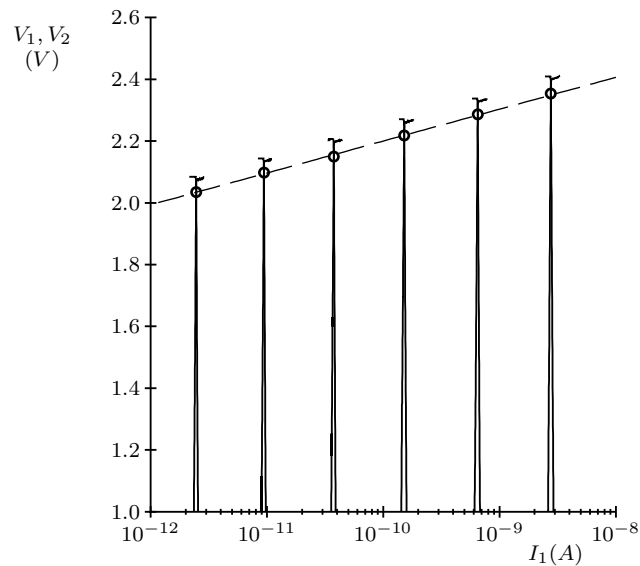


Figure 4 The experiment of Figure 3 is repeated for several values of I_2 ; experimental data of output voltage response are plotted versus absolute input current on a log scale. The output voltage $V_1 = V_2$ is highlighted with a circle for each experiment. The dashed line is a theoretical expression confirming logarithmic behavior over four orders of magnitude (Equation 1).

The conductance of transistors T_{11} and T_{12} determines the losing response of the circuit. The Early voltage, V_e , is a measure of the conductance of a saturated MOS transistor. The expression

$$V_e = L \frac{\partial V_d}{\partial L} \quad (3)$$

defines the Early voltage, where V_d is the drain potential of a transistor, and L is the channel length of a transistor. Thus, the width of the losing response of the circuit depends on the channel length of transistors T_{11} and T_{12} . Figure 3 shows data for a circuit where the channel length of transistors T_{11} and T_{12} is $13.5\mu\text{m}$. Figure 5 shows data for a circuit with a wider losing response; in this circuit, the channel length for transistors T_{11} and T_{12} is $3\mu\text{m}$, the smallest allowable in the fabrication technology used.

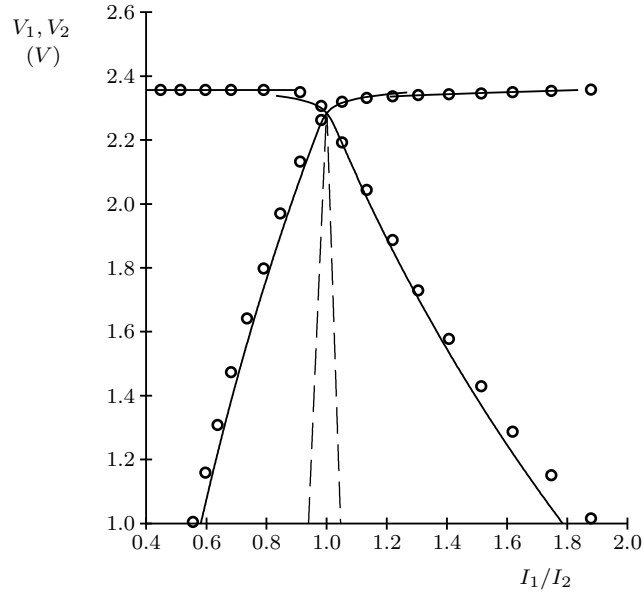


Figure 5 Experimental data (circles) and theoretical statements (solid lines) for a two-neuron winner-take-all circuit with a channel length for transistors T_{11} and T_{12} of $3\mu\text{m}$. The dotted lines show the losing response for the circuit used in Figure 3, which has a channel length for transistors T_{11} and T_{12} of $13.5\mu\text{m}$.

Increasing the channel length of transistors T_{11} and T_{12} narrows the losing response of the circuit; alternatively, circuit modification also can narrow the losing response. The circuit shown in Figure 6 approximately halves the width of the original losing response, through source degeneration of transistors T_{11} and T_{12} by the added diode-connected transistors T_{31} and T_{32} . Figure 7 shows experimental data for this modified circuit.

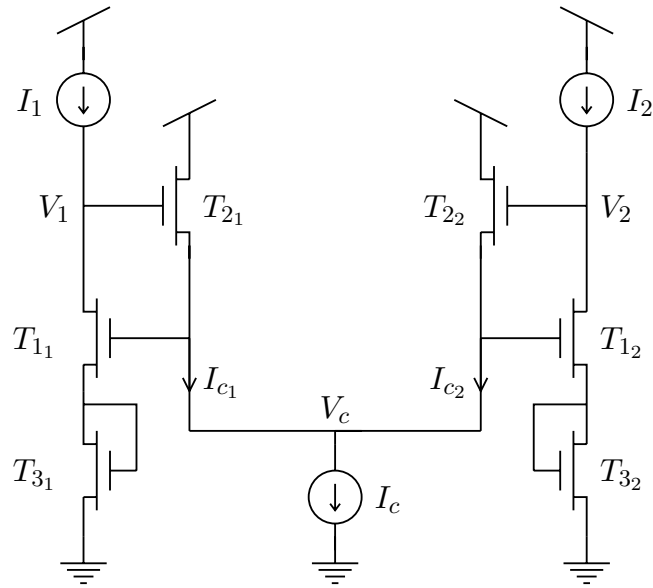


Figure 6 Schematic diagram of a two-neuron winner-take-all circuit, modified to produce a narrower losing response.

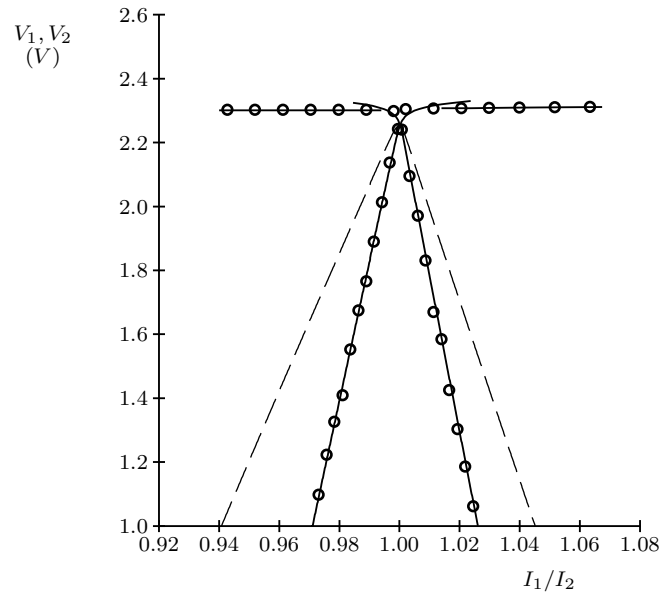


Figure 7 Experimental data (circles) and theoretical statements (solid lines) for a two-neuron winner-take-all circuit, modified to produce a narrower losing response. The dotted lines show losing response for the circuit used in Figure 4.

TIME RESPONSE OF THE WINNER-TAKE-ALL CIRCUIT

A good winner-take-all circuit should be stable, and should not exhibit damped oscillations (“ringing”) in response to input changes. This section explores these dynamic properties of our winner-take-all circuit, and predicts the temporal response of the circuit. Figure 8 shows the two-neuron winner-take-all circuit, with capacitances added to model dynamic behavior.

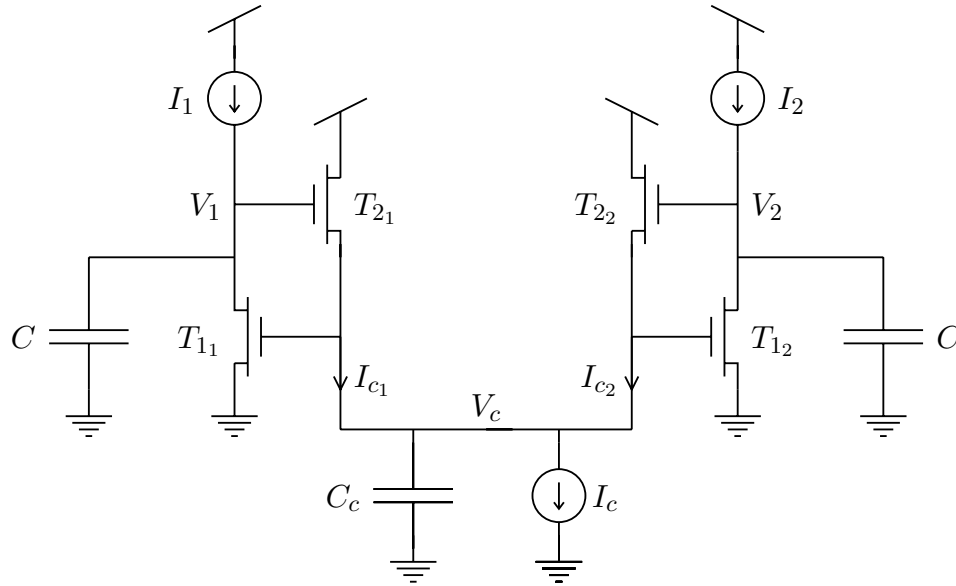


Figure 8 Schematic diagram of a two-neuron winner-take-all circuit, with capacitances added for dynamic analysis. C is a large MOS capacitor added to each neuron for smoothing; C_c models the parasitic capacitance contributed by the gates of T_{11} and T_{12} , the drains of T_{21} and T_{22} , and the interconnect.

Appendix B shows a small-signal analysis of this circuit. The transfer function for the circuit has real poles, and thus the circuit is stable and does not ring, if $I_c > 4I(C_c/C)$, where $I_1 \approx I_2 \approx I$. Figure 9 compares this bound with experimental data.

If $I_c > 4I(C_c/C)$, the circuit exhibits first-order behavior. The time constant CV_o/I sets the dynamics of the winning neuron, where $V_o = kT/q\kappa \approx 40$ mV. The time constant CV_e/I sets the dynamics of the losing neuron, where $V_e \approx 50$ V. Figure 10 compares these predictions with experimental data, for several variants of the winner-take-all circuit.

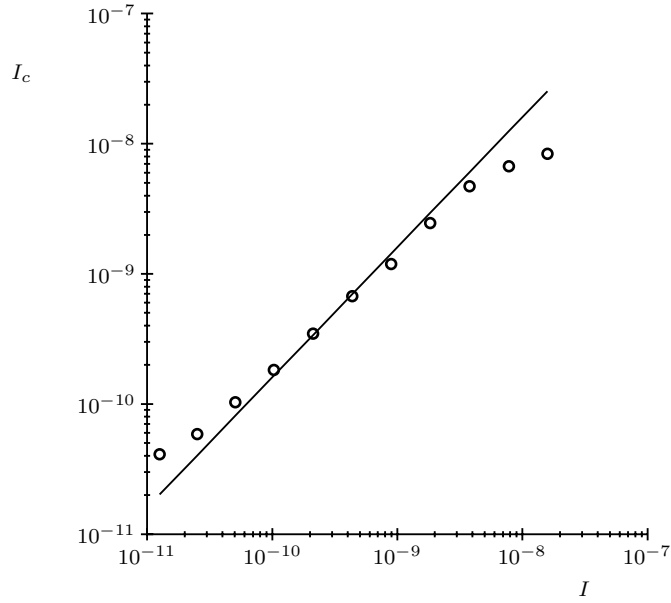


Figure 9 Experimental data (circles) and theoretical statements (solid line) for a two-neuron winner-take-all circuit, showing the smallest I_c , for a given I , necessary for a first-order response to a small-signal step input.

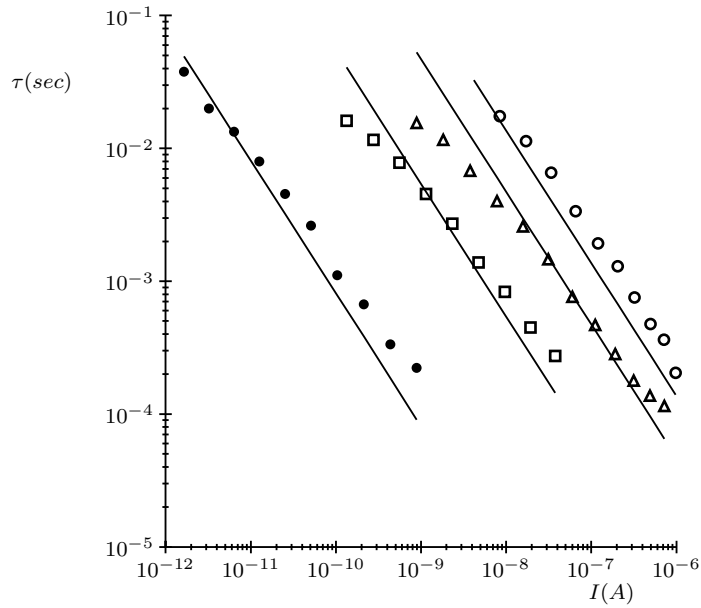


Figure 10 Experimental data (symbols) and theoretical statements (solid line) for a two-neuron winner-take-all circuit, showing the time constant of the first-order response to a small-signal step input. The winning response (filled circles) and losing response (triangles) of a winner-take-all circuit with the static response of Figure 3 are shown; the time constants differ by several orders of magnitude. Losing responses for winner-take-all circuits with the static responses shown in Figure 5 (squares) and Figure 7 (open circles) are also shown, demonstrating the effect of the width of static response on dynamic behavior.

THE LOCAL NONLINEAR INHIBITION CIRCUIT

The winner-take-all circuit in Figure 1, as previously explained, locates the largest input to the circuit. Figure 11 shows this behavior. Figure 11(a) is the spatial input to a winner-take-all circuit with 16 neurons, with input 8 much higher than all other inputs. Figure 11(b) shows the circuit response to this input; only neuron 8 has significant response.

Certain applications require a gentler form of nonlinear inhibition. Sometimes, a circuit that can represent multiple intensity scales is necessary. Without circuit modification, the winner-take-all circuit in Figure 1 can perform this task. Appendix C explains this mode of operation.

Other applications require a local winner-take-all computation, with each winner having influence over only a limited spatial area. Figure 11(c) shows the desired computation. As in Figure 11(b), neuron 8 has the largest response in the circuit. However, neuron 8 suppresses the output of only nearby neurons; neurons far from neuron 8 have significant responses, encoding their input signals.

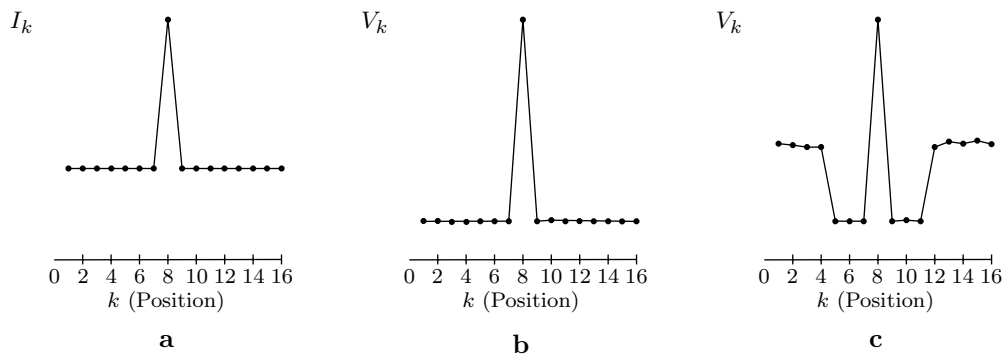


Figure 11 Comparison of idealized winner-take-all spatial response and the desired local winner-take-all response. The horizontal axis of each plot represents spatial position in a 16-neuron network. (a) The plot shows a spatial impulse function, used as input to compare the two concepts. The vertical axis shows the input current to each neuron, with $I_8 \gg I_{k \neq 8}$. (b) The plot shows the winner-take-all response. (c) The plot shows the local winner-take-all response, show neuron voltage output on the vertical axis.

Figure 12 shows a circuit that computes the local winner-take-all function. The circuit is identical to the original winner-take-all circuit, except that each neuron connects to its nearest neighbors with a nonlinear resistor circuit (Mead, in press). Each resistor conducts a current I_r in response to a voltage ΔV across it, where

$$I_r = I_s \tanh(\Delta V / (2V_o)). \quad (4)$$

I_s , the saturating current of the resistor, is a controllable parameter. The current source I_c , present in the original winner-take-all circuit, is distributed between the resistors in the local winner-take-all circuit.

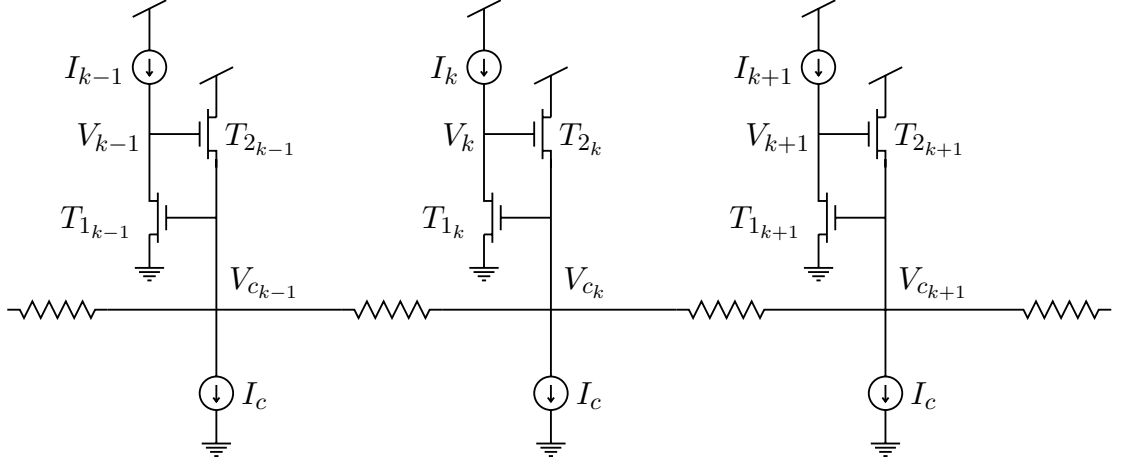


Figure 12 Schematic diagram of a section of the local winner-take-all circuit. Each neuron i receives a unidirectional current input I_i ; the output voltages V_i represent the result of the local winner-take-all computation.

To understand the operation of the local winner-take-all circuit, we consider the circuit response to a spatial impulse, defined as $I_k \gg I$, where $I \equiv I_{i \neq k}$. $I_k \gg I_{k-1}$ and $I_k \gg I_{k+1}$, so V_{c_k} is much larger than $V_{c_{k-1}}$ and $V_{c_{k+1}}$, and the resistor circuits connecting neuron k with neuron $k-1$ and neuron $k+1$ saturate. Each resistor sinks I_s current when saturated; transistor T_{2_k} thus conducts $2I_s + I_c$ current. In the subthreshold region of operation, the equation $I_k = I_o \exp(V_{c_k}/V_o)$ describes transistor T_{1_k} , and the equation $2I_s + I_c = I_o \exp((V_k - V_{c_k})/V_o)$ describes transistor T_{2_k} . Solving for V_k yields

$$V_k = V_o \ln((2I_s + I_c)/I_o) + V_o \ln(I_k/I_o). \quad (5)$$

As in the original winner-take-all circuit, the output of a winning neuron encodes the logarithm of that neuron's associated input.

As mentioned, the resistor circuit connecting neuron k with neuron $k-1$ sinks I_s current. The current sources I_c associated with neurons $k-1, k-2, \dots$ must supply this current. If the current source I_c for neuron $k-1$ supplies part of this current, the transistor $T_{2_{k-1}}$ carries no current, and the neuron output V_{k-1} approaches zero. Similar reasoning applies to neurons $k+1, k+2, \dots$. In this way, a winning neuron inhibits its neighboring neurons.

This inhibitory action does not extend throughout the network. Neuron k needs only I_s current from neurons $k-1, k-2, \dots$. Thus, neurons sufficiently distant from neuron k maintain the service of their current source I_c , and the outputs of

these distant neurons can be active. Since, for a spatial impulse, all neurons $k - 1$, $k - 2, \dots$ have an equal input current I , all distant neurons have the equal output

$$V_{i \ll k} = V_o \ln(I_c/I_o) + V_o \ln(I/I_o). \quad (6)$$

Similar reasoning applies for neurons $k + 1, k + 2, \dots$.

The relative values of I_s and I_c determine the spatial extent of the inhibitory action. Figure 13 shows the spatial impulse response of the local winner-take-all circuit, for different settings of I_s/I_c .

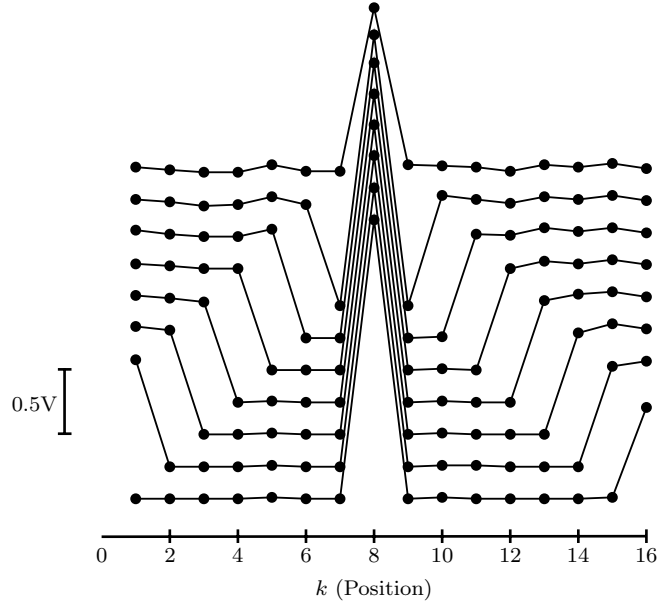


Figure 13 Experimental data showing the spatial impulse response of the local winner-take-all circuit, for values of I_s/I_c ranging over a factor of 12.7. Wider inhibitory responses correspond to larger ratios. For clarity, the plots are vertically displaced in 0.25 volt increments.

CONCLUSIONS

The circuits described in this paper use the full analog nature of MOS devices to realize an interesting class of neural computations efficiently. The circuits exploit the physics of the medium in many ways. The winner-take-all circuit uses a single wire to compute and communicate inhibition for the entire circuit. Transistor T_{1k} in the winner-take-all circuit uses two physical phenomena in its computation: its exponential current function encodes the logarithm of the input, and the finite conductance of the transistor defines the losing output response. As evolution exploits all the physical properties of neural devices to optimize system performance, designers of synthetic neural systems should strive to harness the full potential of the physics of their media.

APPENDIX A

STATIC RESPONSE OF THE WINNER-TAKE-ALL CIRCUIT

Figure 3 in the main text compares data from the two-neuron winner-take-all circuit with a closed-form theoretical statement describing the losing and crossover response of the circuit. This appendix derives this theoretical statement.

Figure A1 shows a small-signal circuit model of the two-neuron winner-take-all circuit (Figure 2 in the main text). For a particular operating point $[I_1, I_2, I_{c1}, I_{c2}]$, the model shows the effect of a small change in I_1 , denoted i_1 , on the circuit voltages V_1, V_2 , and V_c , indicated by the small-signal voltages v_1, v_2 , and v_c . In this model, a linear resistor r_{i_j} , in parallel with a linear dependent current source, with a conductance g_{i_j} , replaces each transistor T_{i_j} from Figure 2. For a particular operating point in subthreshold, the small-signal parameters are

$$\begin{aligned} g_{11} &= I_1/V_o & g_{21} &= I_{c1}/V_o & r_{11} &= V_e/I_1 & r_{21} &= V_e/I_{c1} \\ g_{12} &= I_2/V_o & g_{22} &= I_{c2}/V_o & r_{12} &= V_e/I_2 & r_{22} &= V_e/I_{c2}, \end{aligned} \quad (\text{A1})$$

where V_e , the Early voltage, is a measure of transistor resistance, and $V_o = kT/q\kappa$. This small-signal model is a linear system, which we can solve analytically using conventional techniques; applying the approximation $V_e + V_o \approx V_e$ to the solution yields the simplified equations

$$\begin{aligned} \frac{v_1}{i_1} &= (1/I_1)(V_o + V_e(I_{c2}/I_c)) \\ \frac{v_2}{i_1} &= -V_e(1/I_1)(I_{c1}/I_c). \end{aligned} \quad (\text{A2})$$

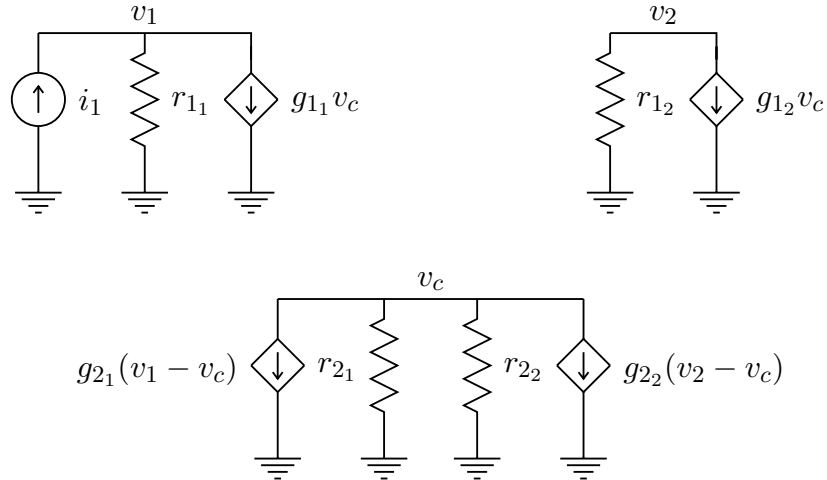


Figure A1 Small-signal model of the two-neuron winner-take-all circuit.

Note that both small- and large-signal quantities appear in Equation A2. We can view the small-signal quantities as differential elements of large-signal quantities; as a result, we can rewrite Equation A2 as the pair of nonlinear differential equations

$$\begin{aligned}\frac{dV_1}{dI_1} &= (1/I_1)(V_o + V_e(I_{c_2}/I_c)) \\ \frac{dV_2}{dI_1} &= -V_e(1/I_1)(I_{c_1}/I_c).\end{aligned}\tag{A3}$$

Solving this pair of nonlinear differential equations yields a complete description of circuit response. We begin by eliminating I_{c_1} and I_{c_2} from the equations. Referring to Figure 2, the equations

$$\begin{aligned}I_{c_1} &= I_o \exp((V_1 - V_c)/V_o) \\ I_{c_2} &= I_o \exp((V_2 - V_c)/V_o)\end{aligned}\tag{A4}$$

describe transistors T_{2_1} and T_{2_2} . From Kirchoff's current law, we know that $I_{c_1} + I_{c_2} = I_c$; substitution of Equation A4 into this equation yields the expression

$$I_c = I_o \exp((V_1 - V_c)/V_o) + I_o \exp((V_2 - V_c)/V_o).\tag{A5}$$

Dividing Equation A4 by Equation A5 eliminates V_c , leaving, after rearrangement,

$$\begin{aligned}I_{c_1}/I_c &= \frac{1}{1 + \exp((V_2 - V_1)/V_o)} \\ I_{c_2}/I_c &= \frac{1}{1 + \exp((V_1 - V_2)/V_o)}.\end{aligned}\tag{A6}$$

These expressions fit nicely into Equation A3, eliminating I_{c_1} and I_{c_2} , and leaving a set of differential equations involving only V_1 , V_2 , and I_1 :

$$\frac{dV_1}{dI_1} = (1/I_1)(V_o + V_e(\frac{1}{1 + \exp((V_1 - V_2)/V_o)}))\tag{A7a}$$

$$\frac{dV_2}{dI_1} = -V_e(1/I_1)(\frac{1}{1 + \exp((V_2 - V_1)/V_o)}).\tag{A7b}$$

Equation A7a contains V_2 only in the subexpression

$$\frac{1}{1 + \exp((V_1 - V_2)/V_o)},\tag{A8a}$$

and Equation A7b contains V_1 only in the subexpression

$$\frac{1}{1 + \exp((V_2 - V_1)/V_o)}.\tag{A8b}$$

These subexpressions are both *Fermi functions* of the difference $V_1 - V_2$. For $V_1 - V_2 \gg V_o$, subexpression A8a is approximately zero, whereas subexpression A8b is

approximately one; for $V_2 - V_1 \gg V_o$, subexpression A8a is approximately one, whereas subexpression A8b is approximately zero. In the region $V_1 \approx V_2$, we can assume V_1 and V_2 are both changing with the same magnitude of slope relative to I_1 . We can write this approximation as $V_1 - V_2 \approx 2(V_1 - V_m)$ and $V_2 - V_1 \approx 2(V_2 - V_m)$, where, from the qualitative analysis in the main text, $V_m \equiv V_1 = V_2$ when $I_1 = I_2 \equiv I_m$. We can use this approximation to decouple Equations A7a and A7b, producing

$$\begin{aligned}\frac{dV_1}{dI_1} &= (1/I_1)(V_o + V_e(\frac{1}{1 + \exp(2(V_1 - V_m)/V_o)})) \\ \frac{dV_2}{dI_1} &= -V_e(1/I_1)(\frac{1}{1 + \exp(2(V_2 - V_m)/V_o)}).\end{aligned}\tag{A9}$$

We can solve these equations by straightforward integration, yielding, after application of the approximation $V_e + V_o \approx V_e$,

$$\ln(I_1/I_m) = (V_1 - V_m)/V_e + (1/2) \ln(1 + (V_o/V_e) \exp(2(V_1 - V_m)/V_o))\tag{A10a}$$

$$\ln(I_1/I_m) = (V_m - V_2)/V_e + (1/2)(V_o/V_e)(1 - \exp(2(V_2 - V_m)/V_o)).\tag{A10b}$$

Equation A10a predicts the value of I_1 for a given value of V_1 , whereas Equation A10b predicts the value of I_1 for a given value of V_2 ; in this way, these equations are a closed-form approximation of circuit response. To understand the behavior of the circuit, and to evaluate the effect of the approximations $V_1 - V_2 \approx 2(V_1 - V_m)$ and $V_2 - V_1 \approx 2(V_2 - V_m)$, we can simplify Equations A10a and A10b for three regions of interest: $V_1 \approx V_2 \approx V_m$, $V_1 \gg V_m$ while $V_2 \ll V_m$, and $V_1 \ll V_m$ while $V_2 \gg V_m$.

First consider the condition $V_1 \approx V_2 \approx V_m$. In this case, $|V_1 - V_2| \rightarrow 0$, $I_1/I_m \rightarrow 1$, and we can linearize the transcendental functions in Equation's A10a and A10b, yielding the simpler relations

$$\begin{aligned}V_1 &= (V_e/2)((I_1/I_m) - 1) + V_m \\ V_2 &= (V_e/2)(1 - (I_1/I_m)) + V_m.\end{aligned}\tag{A11}$$

In this region, V_1 and V_2 are a linear function of I_1 , with a slope of $\pm V_e/(2I_m)$.

Next, consider the condition $V_1 \gg V_m$ while $V_2 \ll V_m$, valid when $I_1 > I_m$. In Equation A10b, $V_2 \ll V_m$ implies $\exp(2(V_2 - V_m)/V_o) \rightarrow 0$. This simplification yields, after rearrangement,

$$V_2 = V_o/2 + V_m - V_e \ln(I_1/I_m).\tag{A12}$$

If we use the notation $I_1 = I_m + \delta_i$, as in the earlier qualitative analysis, we can rewrite the subexpression $\ln(I_1/I_m)$ as $\ln(1 + (\delta_i/I_m))$, which we can approximate as δ_i/I_m for small δ_i/I_m , yielding the simplified result

$$V_2 = V_o/2 + V_m - (V_e/I_m)\delta_i.\tag{A13}$$

Thus, in this region, V_2 decreases linearly with δ_i , with a slope of V_e/I_m , which is twice as large as in the previous condition.

We can similarly derive a simplified expression for V_1 , for the same condition $V_1 \gg V_m$ while $V_2 \ll V_m$. In Equation A10a, $V_1 \gg V_m$ implies $(V_o/V_e) \exp(2(V_1 - V_m)/V_o) \gg 1$. This approximation yields, after rearrangement,

$$V_1 = V_o \ln(I_1/I_m) + (V_o/2) \ln(V_e/V_o) + V_m. \quad (\text{A14})$$

For this condition, as predicted earlier in Equation 2 in the main text, V_1 is a logarithmic function of I_1 . However, when does the approximation $(V_o/V_e) \exp(2(V_1 - V_m)/V_o) \gg 1$ hold? This inequality, when rearranged, yields the constraint

$$(V_1 - V_m) \gg (V_o/2) \ln(V_e/V_o). \quad (\text{A15})$$

Therefore, for a typical fabrication process, $V_1 - V_m$ must be much greater than 0.15 volts for Equation A14 to hold! This error stems from the central approximation $V_1 - V_2 \approx 2(V_1 - V_m)$, which is valid for only $V_1 - V_2 \leq V_o$. Thus, for this region of operation, Equation 2 in the main text best predicts circuit behavior.

Finally, we consider the condition $V_1 \ll V_m$ while $V_2 \gg V_m$, valid when $I_1 < I_m$. In Equation A10a, $V_1 \ll V_m$ implies $(V_o/V_e) \exp(2(V_1 - V_m)/V_o) \rightarrow 0$. This simplification yields, after rearrangement,

$$V_1 = V_m + V_e \ln(I_1/I_m). \quad (\text{A16})$$

If we use the notation $I_1 = I_m - \delta_i$, as in the earlier analysis, we can rewrite the subexpression $\ln(I_1/I_m)$ as $\ln(1 - (\delta_i/I_m))$, which we can approximate as $-\delta_i/I_m$ for small $|\delta_i/I_m|$, yielding the simplified result

$$V_1 = V_m - (V_e/I_m)\delta_i. \quad (\text{A17})$$

Thus, in this region, V_1 decreases linearly with δ_i , with a slope of V_e/I_m . The losing responses for V_1 and V_2 are thus identical.

We can similarly derive a simplified expression for V_2 , for the same condition $V_1 \ll V_m$ while $V_2 \gg V_m$. For Equation A10b, $V_2 \gg V_m$ implies $\exp(2(V_2 - V_m)/V_o) \gg 1$. This approximation yields, after rearrangement,

$$\ln(I_1/I_m) = (V_m - V_2)/V_e - (1/2)(V_o/V_e) \exp(2(V_2 - V_m)/V_o). \quad (\text{A18})$$

As $V_2 - V_m$ increases, the right side of this equation grows exponentially large and negative, forcing I_1 to grow closer and closer to zero; thus, V_2 is constant with I_1 . However, the poor approximation $V_2 - V_1 \approx 2(V_2 - V_m)$ for $V_2 - V_1 \geq V_o$ stunts this exponential growth. The qualitative analysis in the main text predicts this constant value accurately, as

$$V_2 = V_o \ln\left(\frac{I_m}{I_o}\right) + V_o \ln\left(\frac{I_c}{I_o}\right). \quad (\text{A19})$$

In summary, Equations A10a and A10b predict the losing and crossover response of the circuit, whereas Equations 2 and A19 predict the winning response of the circuit. Figure 4 is a plot of this analysis, fitted to experimental data. Figure A2 expands the crossover region of Figure 4, showing the crossover region between losing and winning analysis. The theoretical predictions in Figure 5 and Figure 7 also use this analysis, with altered values of V_e .

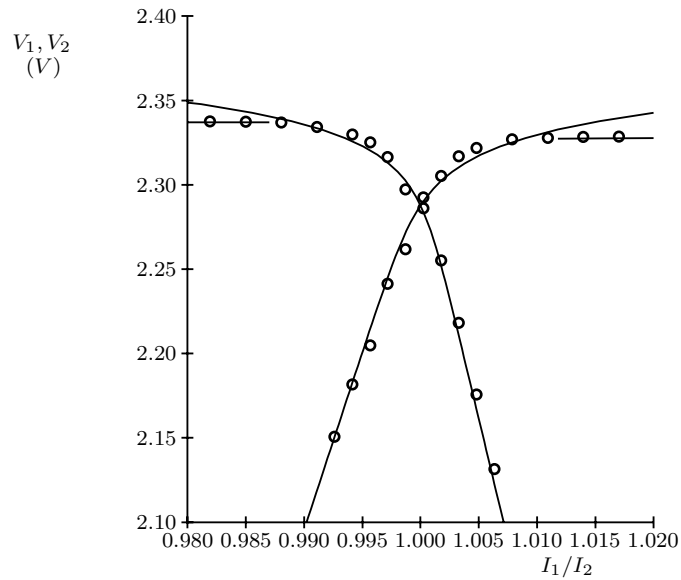


Figure A2 Experimental data (circles) and theoretical statements (solid lines) for a two-neuron winner-take-all circuit in the crossover region.

APPENDIX B

DYNAMIC RESPONSE OF THE WINNER-TAKE-ALL CIRCUIT

In the main text, we presented theoretical predictions of the time response of the winner-take-all circuit, and compared these predictions with experimental data, in Figure 9 and 10. In this appendix, we derive these theoretical predictions.

Figure 8 in the main text shows a schematic diagram for a two-neuron winner-take-all circuit, with capacitances added to model dynamic behavior. Figure B1 shows a small-signal circuit model for this circuit.

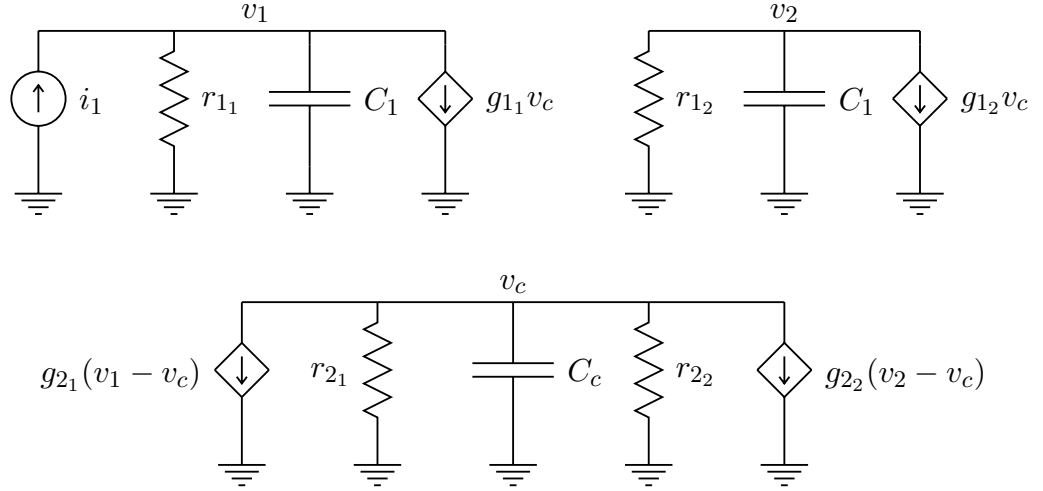


Figure B1 Small-signal model of the two-neuron winner-take-all circuit, with capacitances added to model dynamic behavior.

For a particular operating point $[I_1, I_2, I_{c_1}, I_{c_2}]$, the model shows the effect of a small change in I_1 , notated i_1 , on the circuit voltages V_1, V_2 , and V_c , indicated by the small-signal voltages v_1, v_2 , and v_c . In this model, a linear resistor r_{ij} , in parallel with a linear dependent current source, with a conductance g_{ij} , replaces each transistor T_{ij} from Figure 2. For a particular operating point in subthreshold, the small-signal parameters are

$$\begin{aligned}
 g_{11} &= I_1/V_o & g_{21} &= I_{c_1}/V_o & r_{11} &= V_e/I_1 & r_{21} &= V_e/I_{c_1} \\
 g_{12} &= I_2/V_o & g_{22} &= I_{c_2}/V_o & r_{12} &= V_e/I_2 & r_{22} &= V_e/I_{c_2},
 \end{aligned} \tag{B1}$$

where V_e , the Early voltage, is a measure of transistor resistance, and $V_o = kT/q\kappa$. This small-signal circuit model is a linear system, which we can solve analytically using conventional techniques. The resulting solution, unfortunately, is a function of the unsolved large signal I_{c_1} and I_{c_2} . However, for the input conditions $I_2 = I_m$ and $I_1 = I_m + \delta_i$, we can reasonably make the approximations $I_{c_1} \approx I_c$ and $I_{c_2} \approx 0$ for relatively small δ_i , due to the exponential dependence of T_{21} and T_{22} on V_1 and

V_2 . Using these approximations, we can express the small-signal voltages v_1 and v_2 as linear functions of the small-signal input current i_1 , as

$$\frac{v_1}{i_1} = \left(\frac{V_o}{I_1}\right) \frac{((C_c V_o / I_c) s + 1)}{(s / (a + b) + 1)(s / (a - b) + 1)} \quad (B2)$$

and

$$\frac{v_2}{i_1} = -\left(\frac{V_e}{I_1}\right) \frac{1}{((C V_e / I_2) s + 1)(s / (a + b) + 1)(s / (a - b) + 1)} \quad (B3)$$

where

$$a = \frac{I_1}{2C V_e} + \frac{I_c}{2C_c V_o} \quad (B4)$$

and

$$b = \sqrt{\left(\frac{I_1}{2C V_e}\right)^2 + \left(\frac{I_c}{2C_c V_o}\right)^2 - \left(\frac{I_c I_1}{C C_c V_o^2}\right)}. \quad (B5)$$

If b is an imaginary number, the circuit has complex poles, and exhibits undesirable ringing behavior. If $I_c > 4I_1(C_c/C)$, then b is real, and ringing does not occur. Figure 9 in the main text compares experimental data with this inequality.

When b is real, the circuit exhibits first-order behavior. We can simplify Equations B2 and B3, and show that the first-order time constant for V_1 is $C V_o / I$, and the first-order time constant for V_2 is $C V_e / I$, where $I_1 \approx I_2 \equiv I$. Figure 10 in the main text compares experimental data with these time constants.

APPENDIX C

REPRESENTING MULTIPLE INTENSITY SCALES

This appendix explains a regime of operation of the winner-take-all circuit that represents multiple input intensity scales in the output, while still functioning as an inhibitory circuit.

Consider an N -neuron winner-take-all circuit, with input currents $I_1 \gg I_2 \gg \dots \gg I_N$. As shown in Equation 1 in the main text, the output voltage V_1 is

$$V_1 = V_o \ln\left(\frac{I_1}{I_o}\right) + V_o \ln\left(\frac{I_c}{I_o}\right), \quad (C1)$$

while $V_2 \dots V_N$ are approximately zero. The output does not represent the input ordering $I_2 \gg I_3 \gg \dots \gg I_N$; the largest input wins, and all other inputs lose. We can operate the circuit in another regime, however, which allows inputs $I_1 \dots I_k$ to win, and inputs $I_{k+1} \dots I_N$ to lose, where the magnitude of I_k is under external control. Voltage outputs $V_1 \dots V_{k-1}$ are now binary representations, while V_k maintains a logarithmic encoding of the input current I_k .

In previous analysis in this paper, we used ideal current sources to represent $I_1 \dots I_N$. In Figure C1, we replace these ideal sources with transistor realizations.

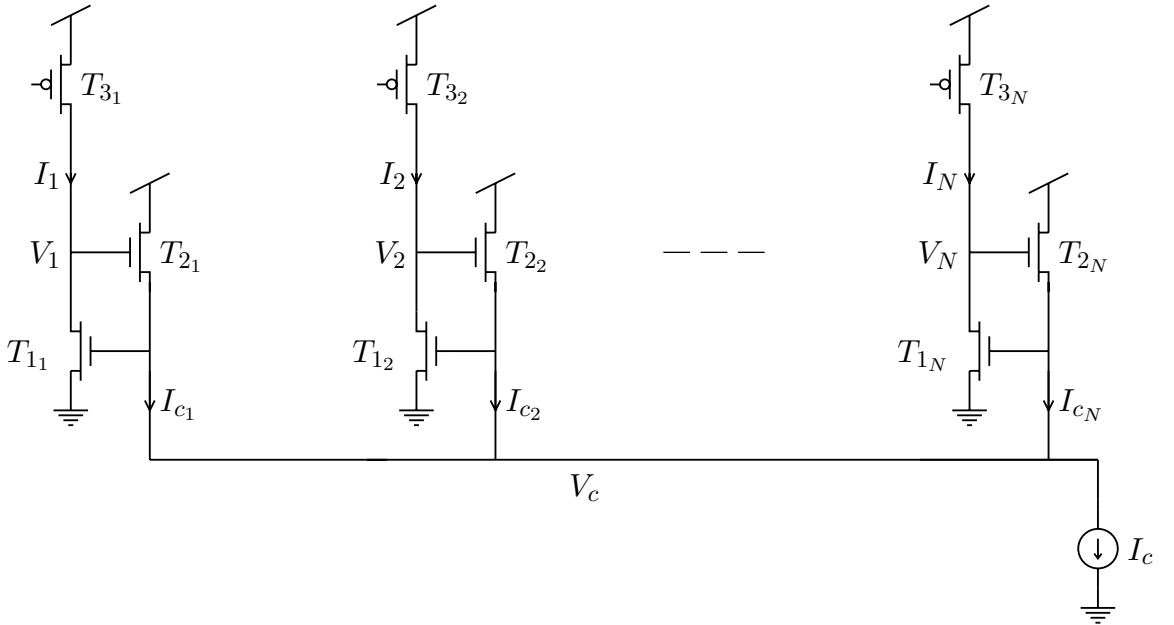


Figure C1. Winner-take-all circuit, with transistors realizations replacing ideal input current sources.

Transistors $T_{3_1} \dots T_{3_N}$, when operating in the subthreshold region, realize ideal current sources if $V_{dd} - V_k > 2V_o$. Recall our input $I_1 \gg I_2 \gg \dots \gg I_N$, and consider

the effect of increasing the value of current source I_c . As shown in Equation C1, the neuron output V_1 increases with I_c . For large I_c , transistor T_{2_1} is no longer operating in the subthreshold region. In this case, the equation $I_{c_1} = k'(W/L)(V_1 - V_c - V_T)^2$ describes T_{2_1} , where W and L are the width and length of T_{2_1} , and k' and V_T (the threshold voltage) are fabrication constants. We can solve for V_1 for this situation, as

$$V_1 = V_o \ln\left(\frac{I_1}{I_o}\right) + \sqrt{\frac{I_c}{k'(W/L)}} + V_T. \quad (C2)$$

If we increase I_c further, V_1 continues to increase. For a sufficiently large I_c , V_1 can approach V_{dd} . In this situation, T_{3_1} begins to turn off, and no longer acts as an ideal current source supplying I_1 . In this case, we can model T_{2_1} as an independent current source, supplying the current $I_s \equiv k'(W/L)(V_{dd} - V_c)^2$, as shown in Figure C2.

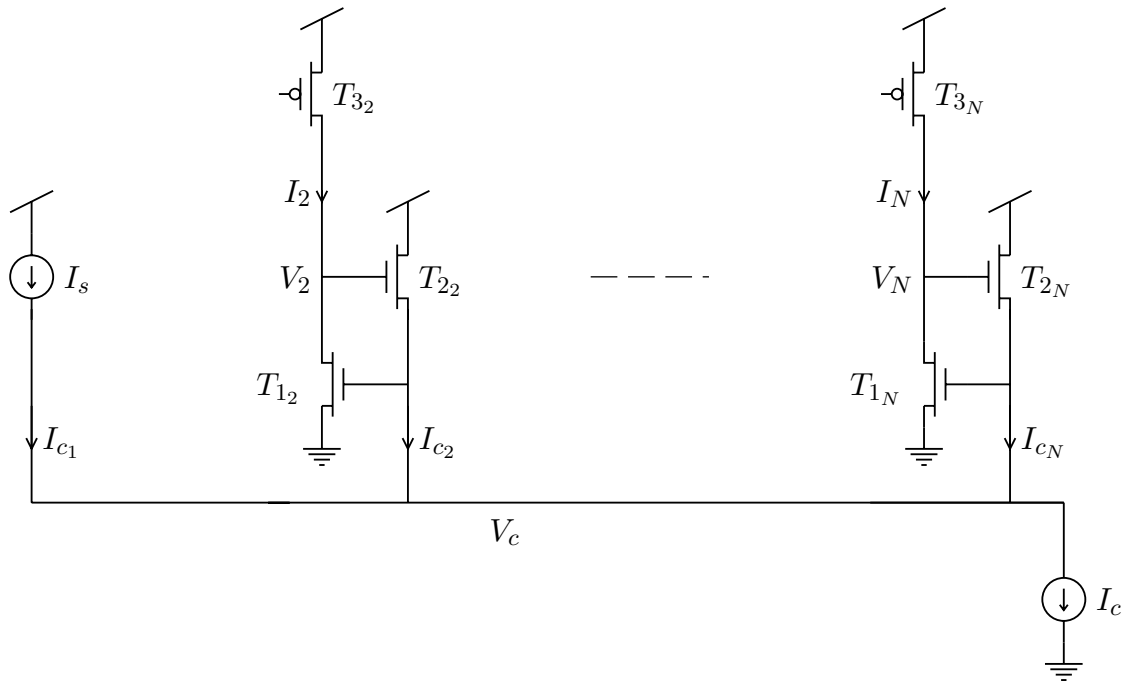


Figure C2. Winner-take-all circuit, after modeling a saturated neuron with the independent current source I_s .

To a first approximation, Figure C2 shows a $(N - 1)$ neuron winner-take-all circuit, with an effective control current of $I_c - I_s$.

We can apply this technique to represent multiple input intensity scales. Recall the input condition $I_1 \gg I_2 \gg \dots \gg I_N$, and the desired behavior of outputs: $V_1 \dots V_{k-1}$ to be binary on, V_k to maintain a logarithmic encoding of the input current I_k , and all other output voltages to be approximately zero. To produce this behavior, we simply increase I_s , until $V_1 \dots V_{k-1}$ are approximately V_{dd} , but $V_k < V_{dd}$.

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